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Application/Control No.

10/617,055

Examiner

Emeka Ebirim

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2166

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Updated	Updated	7/20/2006	EE

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	7/20/2006	EE
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